

RoHS Compliant Product  
A suffix of "-C" specifies halogen free

## DESCRIPTION

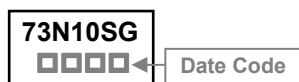
The SSD73N10SG-C is the highest performance trench N-Ch MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The SSD73N10SG-C meet the RoHS and Green Product with Function reliability approved.

## FEATURES

- $R_{DS(ON)} \leq 11m\Omega$  @  $V_{GS}=10V$
- $R_{DS(ON)} \leq 14m\Omega$  @  $V_{GS}=4.5V$
- High Speed Power Switching, Logic Level
- Enhanced Body diode dv/dt capability
- Enhanced Avalanche Ruggedness
- 100% UIS Tested, 100% Rg Tested

## MARKING



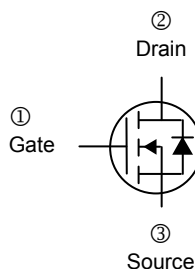
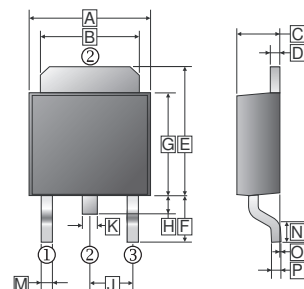
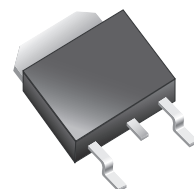
## PACKAGE INFORMATION

| Package | MPQ  | Leader Size |
|---------|------|-------------|
| TO-252  | 2.5K | 13 inch     |

## ORDER INFORMATION

| Part Number  | Type                            |
|--------------|---------------------------------|
| SSD73N10SG-C | Lead (Pb)-free and Halogen-free |

## TO-252(D-Pack)



| REF. | Millimeter |      | REF. | Millimeter |      |
|------|------------|------|------|------------|------|
|      | Min.       | Max. |      | Min.       | Max. |
| A    | 6.3        | 6.9  | J    | 2.3 REF.   |      |
| B    | 4.95       | 5.53 | K    | 0.89 REF.  |      |
| C    | 2.1        | 2.5  | M    | 0.45       | 1.14 |
| D    | 0.4        | 0.9  | N    | 1.55 Typ.  |      |
| E    | 6          | 7.7  | O    | 0          | 0.15 |
| F    | 2.90 REF.  |      | P    | 0.58 REF.  |      |
| G    | 5.4        | 6.4  |      |            |      |
| H    | 0.6        | 1.2  |      |            |      |

## ABSOLUTE MAXIMUM RATINGS ( $T_J=25^\circ\text{C}$ unless otherwise specified)

| Parameter  | Symbol          | Ratings                 | Unit               |
|--|-----------------|-------------------------|--------------------|
| Drain-Source Voltage                             | $V_{DS}$        | 100                     | V                  |
| Gate-Source Voltage                              | $V_{GS}$        | $\pm 20$                | V                  |
| Continuous Drain Current (Package Limited)       | $I_D$           | $T_C=25^\circ\text{C}$  | 70                 |
| Continuous Drain Current (Silicon Limited)       |                 | $T_C=25^\circ\text{C}$  | 73                 |
|  |                 | $T_C=100^\circ\text{C}$ | 52                 |
| Pulsed Drain Current                             | $I_{DM}$        | 190                     | A                  |
| Avalanche Energy, Single Pulse, @L=0.1mH         | $E_{AS}$        | 22                      | mJ                 |
| Power Dissipation                                | $P_D$           | 125                     | W                  |
| Operating Junction and Storage Temperature Range | $T_J, T_{STG}$  | -55~175                 | $^\circ\text{C}$   |
| <b>Thermal Resistance Ratings</b>                |                 |                         |                    |
| Maximum Thermal Resistance Junction-Ambient      | $R_{\theta JA}$ | 50                      | $^\circ\text{C/W}$ |
| Maximum Thermal Resistance Junction-Case         | $R_{\theta JC}$ | 1.2                     |                    |

**ELECTRICAL CHARACTERISTICS** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

| Parameter                       | Symbol       | Min.                    | Typ. | Max.      | Unit       | Test conditions  |                                |
|---------------------------------|--------------|-------------------------|------|-----------|------------|--|--------------------------------|
| Drain-Source Breakdown Voltage  | $BV_{DSS}$   | 100                     | -    | -         | V          | $V_{GS}=0, I_D=250\mu\text{A}$   |                                |
| Gate Threshold Voltage          | $V_{GS(th)}$ | 1.4                     | 1.9  | 2.4       | V          | $V_{GS}=V_{DS}, I_D=250\mu\text{A}$  |                                |
| Zero Gate Voltage Drain Current | $I_{DSS}$    | $T_J=25^\circ\text{C}$  | -    | -         | 1          | $\mu\text{A}$  | $V_{DS}=100\text{V}, V_{GS}=0$ |
|                                 |              | $T_J=100^\circ\text{C}$ | -    | -         | 100        |  |                                |
| Gate-Source Leakage Current     | $I_{GSS}$    | -                       | -    | $\pm 100$ | nA         | $V_{GS}=\pm 20\text{V}, V_{DS}=0$  |                                |
| Drain-Source On-Resistance      | $R_{DS(ON)}$ | -                       | 9    | 11        | m $\Omega$ | $V_{GS}=10\text{V}, I_D=20\text{A}$  |                                |
|                                 |              | -                       | 11   | 14        |            | $V_{GS}=4.5\text{V}, I_D=20\text{A}$   |                                |
| Forward Transfer conductance    | $g_{fs}$     | -                       | 60   | -         | S          | $V_{DS}=5\text{V}, I_D=20\text{A}$   |                                |
| Gate Resistance                 | $R_G$        | -                       | 1.5  | -         | $\Omega$   | $V_{GS}=0, V_{DS}$ Open, $f=1\text{MHz}$   |                                |
| Total Gate Charge               | $Q_g$        | -                       | 29   | -         | nC         | $V_{GS}=10\text{V}$  |                                |
|                                 |              | -                       | 14   | -         |            | $V_{GS}=4.5\text{V}$   |                                |
| Gate-Source Charge              | $Q_{gs}$     | -                       | 5    | -         | nC         | $V_{DD}=50\text{V}$<br>$I_D=14\text{A}$  |                                |
| Gate-Drain ("Miller") Change    | $Q_{gd}$     | -                       | 5    | -         |            | $V_{GS}=10\text{V}$  |                                |
| Turn-on Delay Time              | $T_{d(on)}$  | -                       | 8    | -         | nS         | $V_{DD}=50\text{V}$<br>$I_D=14\text{A}$<br>$V_{GS}=10\text{V}$<br>$R_G=10\Omega$ |                                |
| Rise Time                       | $T_r$        | -                       | 3    | -         |            |  |                                |
| Turn-off Delay Time             | $T_{d(off)}$ | -                       | 26   | -         |            |  |                                |
| Fall Time                       | $T_f$        | -                       | 4    | -         |            |  |                                |
| Input Capacitance               | $C_{iss}$    | -                       | 2275 | -         | pF         | $V_{GS}=0$<br>$V_{DS}=50\text{V}$<br>$f=1\text{MHz}$                             |                                |
| Output Capacitance              | $C_{oss}$    | -                       | 162  | -         |            |  |                                |
| Reverse Transfer Capacitance    | $C_{rss}$    | -                       | 7.9  | -         |            |  |                                |
| <b>Source-Drain Diode</b>       |              |                         |      |           |            |  |                                |
| Forward on Voltage              | $V_{SD}$     | -                       | 0.9  | 1.2       | V          | $I_F=20\text{A}, V_{GS}=0$   |                                |
| Reverse Recovery Time           | $T_{rr}$     | -                       | 33   | -         | nS         | $V_R=50\text{V}, I_F=12\text{A}$   |                                |
| Reverse Recovery Charge         | $Q_{rr}$     | -                       | 157  | -         | nC         | $di_F/dt=500\text{A}/\mu\text{s}$  |                                |

**TYPICAL CHARACTERISTICS CURVE**

Fig 1. Typical Output Characteristics

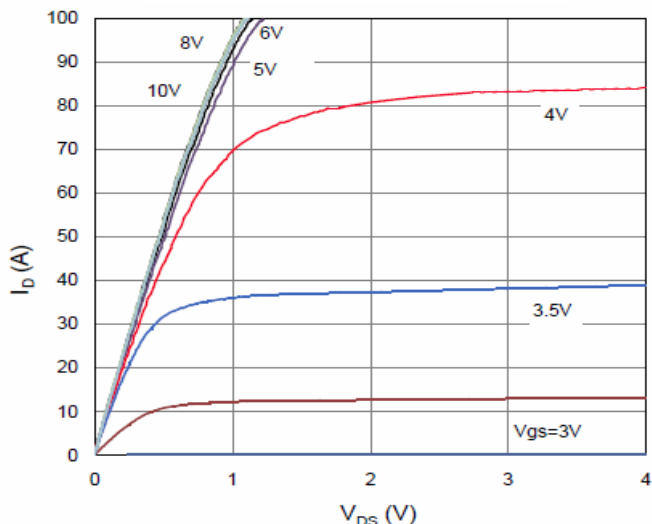


Figure 2. On-Resistance vs. Gate-Source Voltage

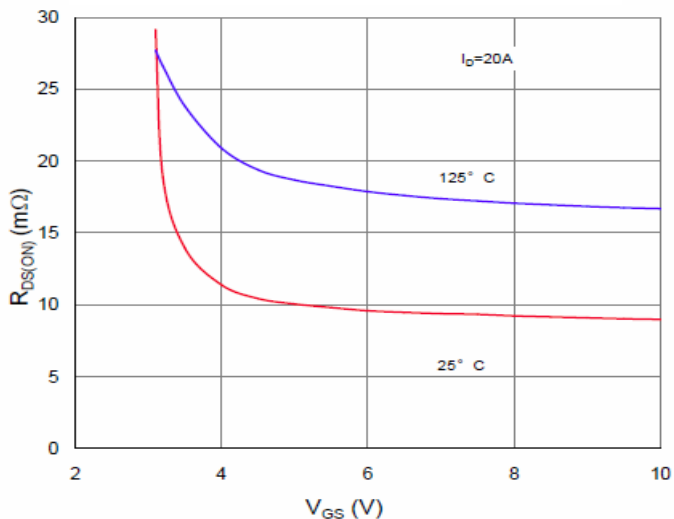


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

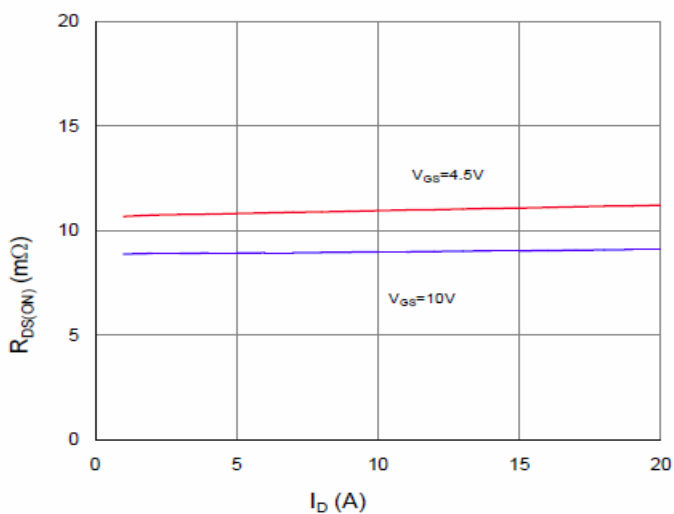


Figure 4. Normalized On-Resistance vs. Junction Temperature

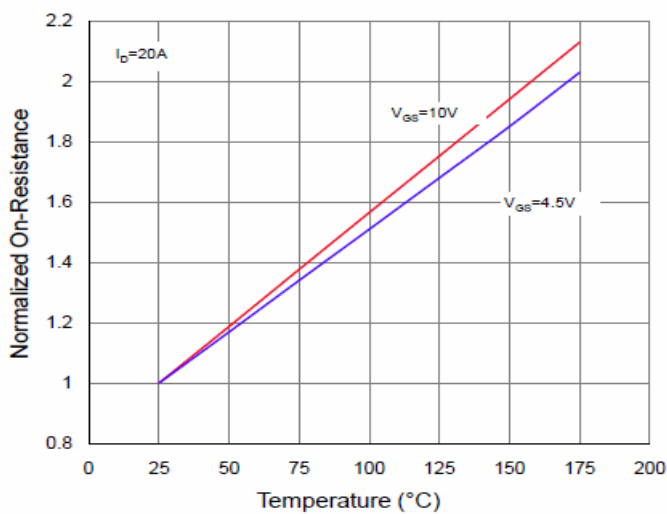


Figure 5. Typical Transfer Characteristics

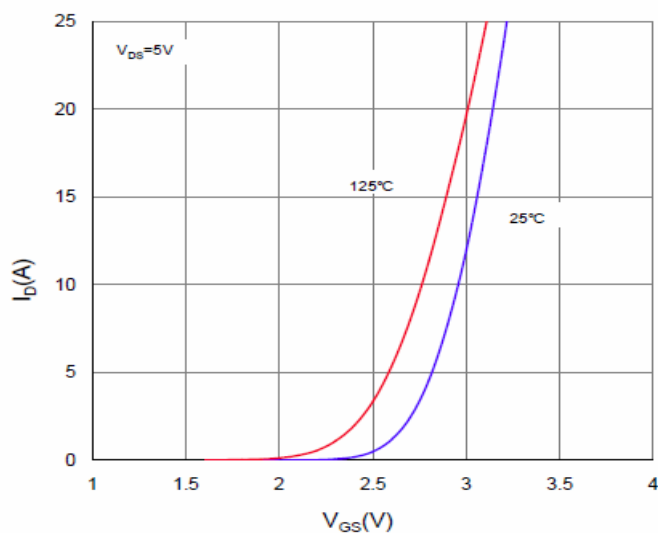
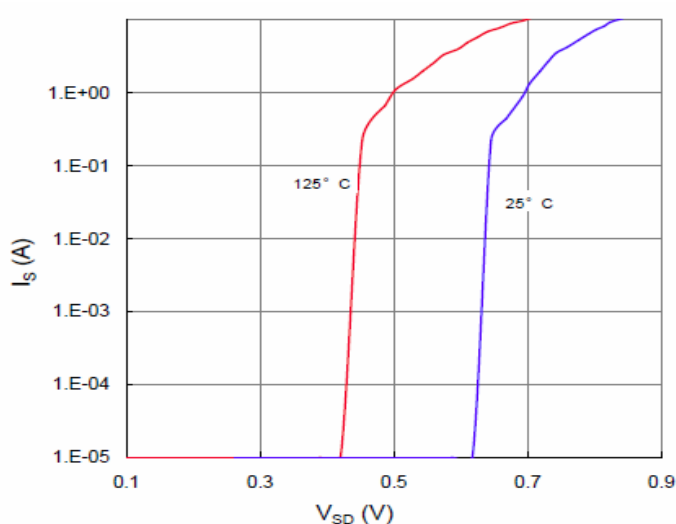


Figure 6. Typical Source-Drain Diode Forward Voltage



**TYPICAL CHARACTERISTICS CURVE**

Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

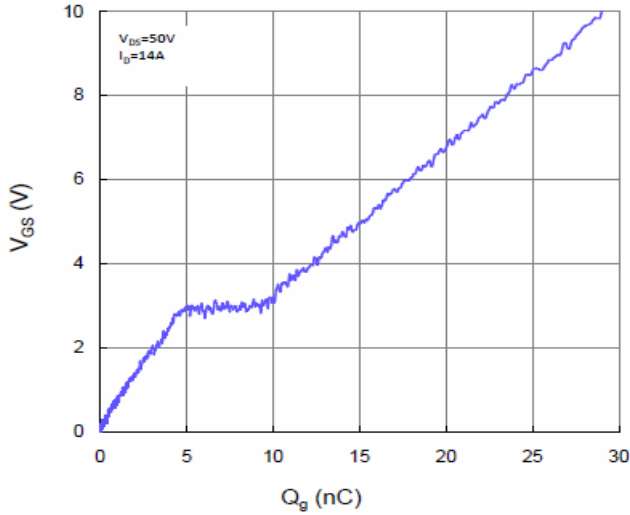


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

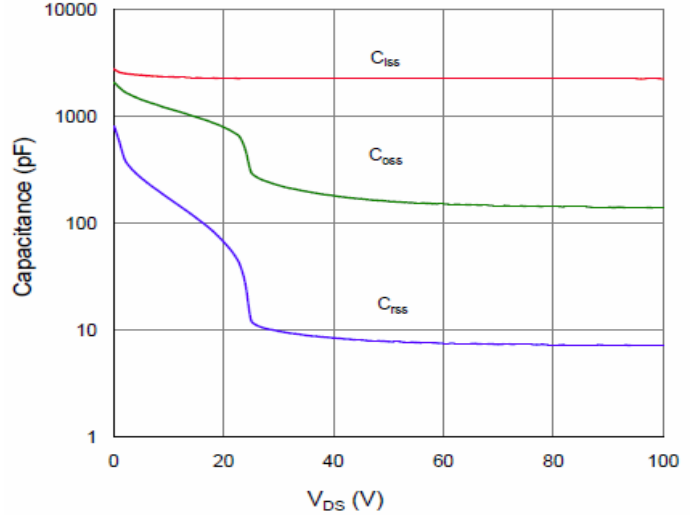


Figure 9. Maximum Safe Operating Area

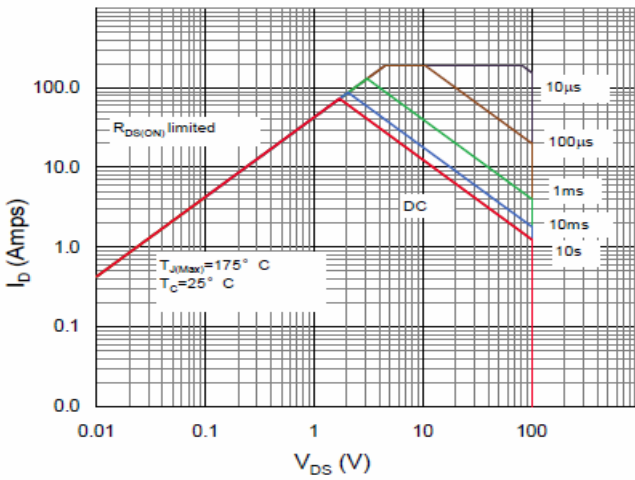


Figure 10. Maximum Drain Current vs. Case Temperature

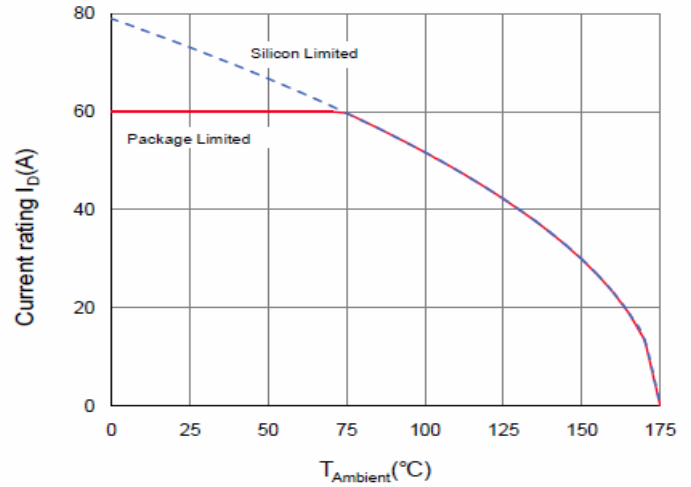


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Ambient

